

## P-Channel Enhancement Mode Field Effect Transistor

### FEATURES

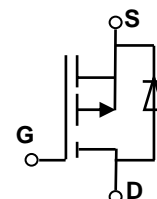
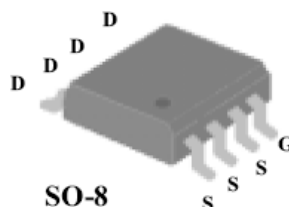
- Super high dense cell design for low  $R_{DS(ON)}$
- Rugged and reliable
- Simple drive requirement
- SOP-8 package

### PRODUCT SUMMARY

$V_{DSS}$	$I_D$	$R_{DS(ON)}$ (m $\Omega$ ) Typ
-30V	-8A	15@ $V_{GS}=-10V$
		20@ $V_{GS}=-4.5V$



NOTE: The MT4435BDY is available in a lead-free package



### ABSOLUTE MAXIMUM RATINGS ( $T_A=25^{\circ}C$ unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	$V_{DS}$	-30	V
Gate-Source Voltage	$V_{GS}$	$\pm 25$	V
Drain Current-Continuous <sup>a</sup> @ $T_j=125^{\circ}C$ - Pulse $d^b$	$I_D$	-8	A
	$I_{DM}$	-40	A
Drain-source Diode Forward Current <sup>a</sup>	$I_S$	-2.4	A
Maximum Power Dissipation <sup>a</sup>	$P_D$	2.5	W
Operating Junction and Storage Temperature Range	$T_j, T_{STG}$	-55 to 150	$^{\circ}C$

### THERMAL CHARACTERISTICS

Thermal Resistance, Junction-to Ambient <sup>a</sup>	$R_{th JA}$	50	$^{\circ}C/W$
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ELECTRICAL CHARACTERISTICS (T<sub>A</sub>=25°C unless otherwise noted)

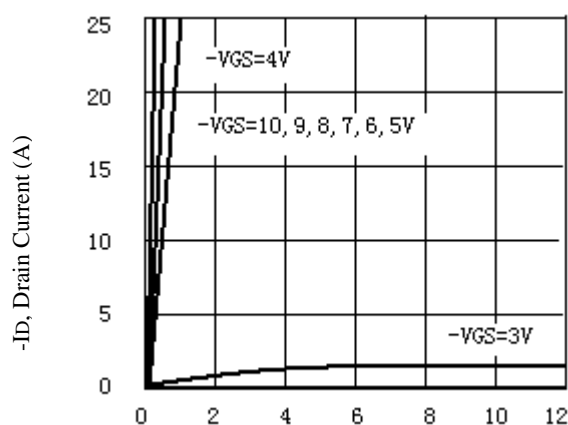
Parameter	Symbol	Condition	Min	Typ	Max	Unit
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V,I <sub>D</sub> =-250μA	-30			V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> =-24V,V <sub>GS</sub> =0V			-1	μA
Gate-Body Leakage	I <sub>GSS</sub>	V <sub>GS</sub> =±20V,V <sub>DS</sub> =0V			±100	nA
ON CHARACTERITICS						
Gate Threshold Voltage	V <sub>GS</sub> (th)	V <sub>DS</sub> =V <sub>GS</sub> ,I <sub>D</sub> =-250μA	-1	-1.6	-2.5	V
Drain-Source On-State Resistance	R <sub>DS</sub> (ON)	V <sub>GS</sub> =-10V,I <sub>D</sub> =-8A		15	17	m Ω
		V <sub>GS</sub> =-4.5V,I <sub>D</sub> =-5.0A		20	22	
Forward Transconductance	g <sub>FS</sub>	V <sub>GS</sub> =-15V,I <sub>D</sub> =-8A		6		S
DAYNAMIC CHARACTERISTICS						
Input Capacitance	C <sub>ISS</sub>	V <sub>DS</sub> =-15V,V <sub>GS</sub> =0V f=1.0MHz		1119		pF
Output Capacitance	C <sub>OSS</sub>			363		pF
Reverse Transfer Capacitance	C <sub>RSS</sub>			138		pF
SWITCHING CHARACTERISISTICS						
Turn-On Delay Time	t <sub>D</sub> (ON)	V <sub>DD</sub> =-15V I <sub>D</sub> =-8A, V <sub>GEN</sub> =-4.5V R <sub>L</sub> =10ohm R <sub>GEN</sub> =6ohm		17.8		ns
Rise Time	t <sub>r</sub>			17.5		ns
Turn-Off Delay Time	t <sub>D</sub> (OFF)			169		ns
Fall Time	t <sub>f</sub>			96		ns
Total Gate Charge	Q <sub>g</sub>	V <sub>DS</sub> =-15V,I <sub>D</sub> =-1A V <sub>GS</sub> =-10V		35		nC
Gate-Source Charge	Q <sub>gs</sub>			3.3		nC
Gate-Drain Charge	Q <sub>gd</sub>			8.1		nC

# ELECTRICAL CHARACTERISTICS (TA=25°C unless otherwise noted)

Parameter	Symbol	Condition	Min	Typ	Max	Unit
DRAIN-SOURCE DIODE CHARACTERISTICS						
Diode Forward Voltage	V <sub>SD</sub>	V <sub>GS</sub> =0V, I <sub>S</sub> =-1.7A		-0.74	-1.2	V

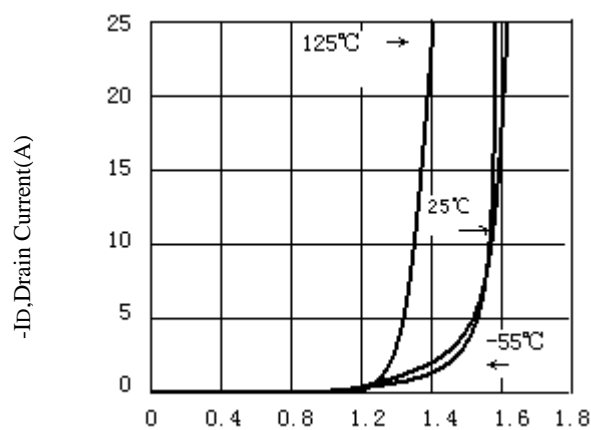
## Notes

- Surface Mounted on FR4 Board, t ≤ 10sec
- Pulse Test: Pulse Width ≤ 300Us, Duty ≤ 2%
- Guaranteed by design, not subject to production testing.



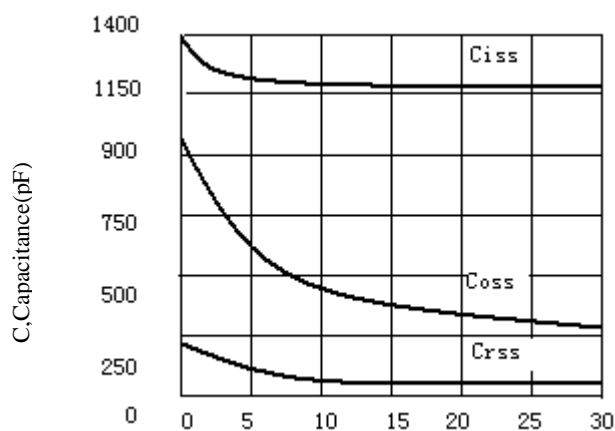
- V<sub>ds</sub>, Drain-to-Source Voltage (V)

Figure 1. Output Characteristics



-V<sub>gs</sub>, Gate-to-source Voltage (V)

Figure 2. Transfer Characteristics



- V<sub>GS</sub>, Drain-to Source Voltage

Figure3. Capacitance

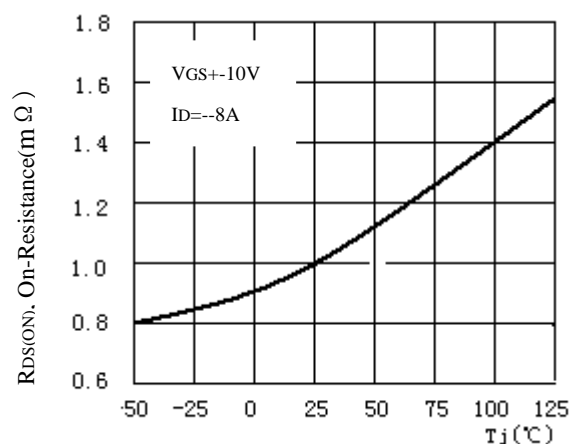
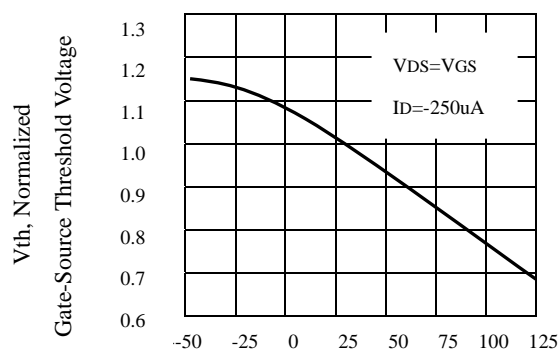
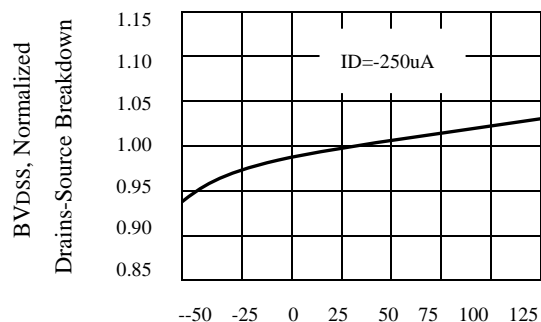


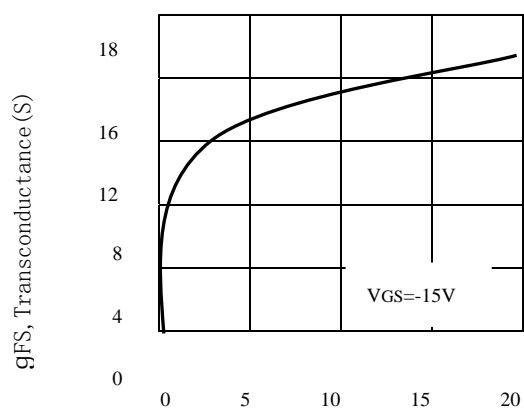
Figure4. On-Resistance Variation with Temperature



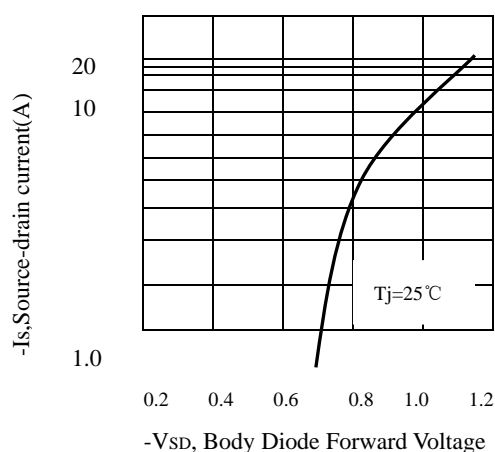
Tj, Junction Temperature(°C)  
Figure5. Gate Threshold Variation  
With Temperature



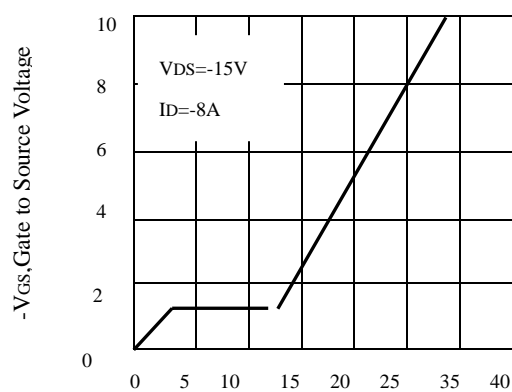
Tj, Junction Temperature (°C)  
Figure6. Breakdown Voltage Variation  
With Temperature



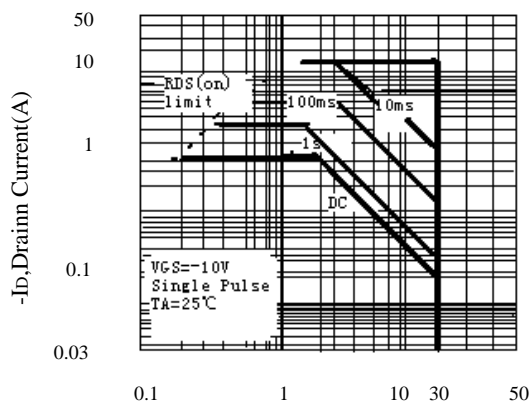
-IDS, Drain-Source Current (A)  
Figure7. Transconductance Variation  
With Drain Current



-VSD, Body Diode Forward Voltage  
Figure8. Body Diode Forward Voltage  
Variation with Source Current



Qg, Total Gate Charge(nC)  
Figure9. Gate Charge



-VDS, Drain-Source Voltage(V)  
Figure10. Maximum Safe Operating Area



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